

Notice of References Cited	Application/Control No. 10/633,264	Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Michael t. Tran	Art Unit 2827	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,514,781	02-2003	Chang et al.	438/19
*	B	US-5,850,113	12-1998	Weimer et al.	307/125
*	C	US-6,473,361	10-2002	Chen et al.	365/244
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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